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U.S. PATENT AND TRADEMARK OFFICE

Attorney Docket No. 35640/36899

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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cant(s):

Matsumoto Toshiyuki et al.

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Nguyen, Tung X.

For:

CAPACITANCE MEASUREMENT METHOD OF MICRO

STRUCTURES OF INTEGRATED CIRCUITS

<u>AMENDMENT</u>

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In response to the official Office Action dated May 25, 2004, please amend the above-identified application as follows:

IN THE CLAIMS

Please see the Claim Summary Document attached hereto.

REMARKS

In response to the official Office Action dated May 25, 2004, Applicant provides the following remarks.

With respect to the objection of the drawings under 37 C.F.R. § 1.83(a) and the rejection of Claim 2 under 35 U.S.C. § 112, the third terminals are the guard terminals T_G 12/15/2004 Showhilm (Warious Offigures Offi) Frigure 12, the two guard terminals T_G are Cbb2 and Cbj. In 01 F0:1701 Figure 178, Whertwo guard terminals T_G are Cbp and Cbj. In Figure 19, the guard terminals T_G are Cwp and Cwg. In Figure 22, the guard terminals T_G are elements 104 and 106. Thus, there is sufficient support in the drawings for a plurality of third terminals.

The allowance of Claims 20-22 is hereby acknowledged. The objection to Claims 3-5, 8 and 11-19 as being directed to allowable subject matter is also acknowledged.

Objected to Claim 4 has been rewritten as an independent claim. Basically, the preamble of Claim 1 has been inserted, and the redundant parts from Claim 1 have not been included. Thus, Claim 4 is considered allowable.